



File No. 4463
U.S. Pat. Appln. Ser. No. 09/762,863

B/A
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT: Euler et al. GROUP: 2877
SERIAL NO: 09/762,863 EXAMINER: Lee, A.
FILED: May 2, 2001
FOR: THIN FILM STRAIN SENSORS BASED ON
INTER-FEROMETRIC OPTICAL MEASUREMENTS

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

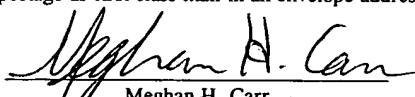
RULE 312 AMENDMENT

IN THE SPECIFICATION:

On page 1, line 3, please insert the following paragraph:

This application, which is a National Stage of International Application No. PCT/US99/19601, filed on August 25, 1999, claims priority to U.S. Provisional Application No. 60/097,989, filed on August 26, 1998.

I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the Commissioner of Patents, P.O. Box 1450 Alexandria, VA 22313-1450.


Meghan H. Carr
08/19/04
Date